Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/643,612	VAN DE MARK ET AL	
Examiner	Art Unit	
Edward J. Cain	1714	

SEARCHED					
Class	Subclass	Date	Examiner		
			· 		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Prior art from parent used. Inv. search	6/26/2005	EC		
,				
		,		